

STN3NF06

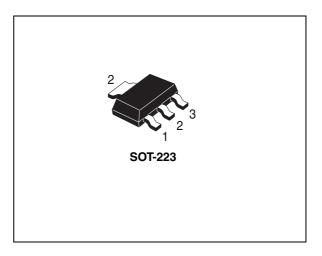
General features

Туре	V _{DSS} (@Tjmax)	R _{DS(on)}	I _D
STN3NF06	60V	<0.1Ω	4A

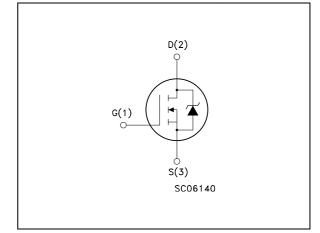
- Exceptional dv/dt capability
- 100% avalanche tested
- Avalanche rugged technology

Description

This Power MOSFET is the latest development of STMicroelectronics unique "Single Feature Size™" strip-based process. The resulting transistor shows extremely high packing density for low on-resistance, rugged avalanche characteristics and less critical alignment steps therefore a remarkable manufacturing reproducibility.



Internal schematic diagram



Applications

Switching application

Order codes

Part number	Marking	Package	Packaging
STN3NF06	N3NF06	SOT-223	Tape & reel

February	2007
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Electrical ratings

Table 1. Absolute maximum ratin	qs
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Symbol	Parameter	Value	Unit
V _{DS}	Drain-source voltage (V _{GS} = 0)	60	V
V _{GS}	Gate-source voltage	± 20	V
I _D	Drain current (continuous) at $T_C = 25^{\circ}C$	4	Α
Ι _D	Drain current (continuous) at T _C =100°C	2.9	Α
I _{DM} ⁽¹⁾	Drain current (pulsed)	16	Α
P _{TOT}	Total dissipation at $T_{C} = 25^{\circ}C$	3.3	W
	Derating factor	0.026	W/°C
dv/dt ⁽²⁾	Peak diode recovery voltage slope	10	V/ns
E _{AS} ⁽³⁾	Single pulse avalanche energy	200	mJ
Т _Ј T _{stg}	Operating junction temperature Storage temperature	-55 to 150	°C

1. Pulse width limited by safe operating area

2. $I_{SD} \leq 4$ A, di/dt ≤ 150 A/µs, $V_{DD} \leq V_{(BR)DSS}$, $T_J \leq T_{JMAX}$

3. Starting $T_j = 25 \text{ }^{o}\text{C}$, $I_D = 4A$, $V_{DD} = 30V$

Table 2. Thermal d

Rthj-pcb	Thermal resistance junction-PCB ⁽¹⁾ max	38	°C/W
Rthj-pcb	Thermal resistance junction-PCB ⁽²⁾ max	100	°C/W
T _I ⁽³⁾	Maximum lead temperature for soldering purpose typ	260	°C

1. When Mounted on FR-4 board with 1 inch² pad, 2 oz. of Cu. and t < 10 sec.

2. When Mounted on minimum recommended footprint

3. for 10 sec. 1.6 mm from case



2 Electrical characteristics

(T_{CASE}=25°C unless otherwise specified)

	•					
Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
V _{(BR)DSS}	Drain-source breakdown voltage	I _D = 250 μA, V _{GS} = 0	60			V
I _{DSS}	Zero gate voltage drain current ($V_{GS} = 0$)	V _{DS} = Max rating, V _{DS} = Max rating @125°C			1 10	μΑ μΑ
I _{GSS}	Gate body leakage current (V _{DS} = 0)	$V_{GS} = \pm 20V$			± 100	nA
V _{GS(th)}	Gate threshold voltage	$V_{DS} = V_{GS}, I_D = 250 \mu A$	2	3	4	V
R _{DS(on)}	Static drain-source on resistance	V _{GS} = 10V, I _D = 1.5A		0.07	0.10	Ω

Table 3. On/off states

Table 4. Dynamic

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
9 _{fs} ⁽¹⁾	Forward transconductance	V _{DS} = 15V, I _D =1.5A		3		S
C _{iss} C _{oss} C _{rss}	Input capacitance Output capacitance Reverse transfer capacitance	V _{DS} =25V, f=1 MHz, V _{GS} =0		315 70 30		pF pF pF
Q _g Q _{gs} Q _{gd}	Total gate charge Gate-source charge Gate-drain charge	V _{DD} =48V, I _D = 3A V _{GS} =10V (see Figure 14)		10 3.5 3.5	13	nC nC nC

1. Pulsed: pulse duration=300µs, duty cycle 1.5%

Table 5. Switching times

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
t _{d(on)} t _r	Turn-on delay time rise time	V _{DD} =30 V, I _D =1.5A, R _G =4.7Ω, V _{GS} =10V (see Figure 13)		7 18		ns ns
t _{d(off)} t _f	Turn-off delay time fall time	V_{DD} =30 V, I _D =1.5A, R _G =4.7Ω, V _{GS} =10V (see Figure 13)		17 6		ns ns



Symbol	Parameter	Test conditions	Min.	Тур.	Max	Unit
I _{SD}	Source-drain current				4	А
$I_{SDM}^{(1)}$	Source-drain current (pulsed)				16	А
V _{SD} ⁽²⁾	Forward on voltage	I _{SD} =4A, V _{GS} =0			1.3	V
t _{rr} Q _{rr} I _{RRM}	Reverse recovery time Reverse recovery charge Reverse recovery current	I _{SD} =4 A, di/dt = 100A/μs, V _{DD} =25 V, Tj=150°C (see Figure 15)		50 88 3.5		ns nC A

 Table 6.
 Source drain diode

1. Pulse width limited by safe operating area.

2. Pulsed: pulse duration=300µs, duty cycle 1.5%



GC9774

 $\begin{array}{c|c} 0.02 \\ \hline 0.01 \\ \hline 0.01 \\ \hline R_{ihj-peb} = 62^{\circ}C/W \end{array}$ Rihj-peb=62°C/W

10¹

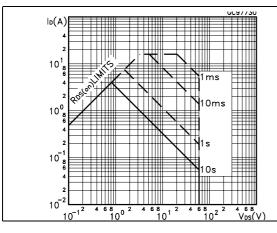
 $\delta = t_{\rm p}/\tau$

to L

 $10^{2} t_{P}(s)$

Electrical characteristics (curves) 2.1

Figure 1. Safe operating area





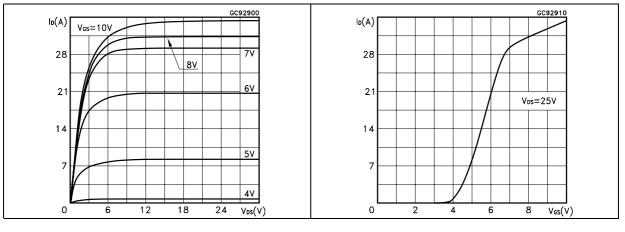


Figure 2.

Κ

10

 10^{-2}

Figure 4.

Thermal impedance

SINGLE PULSE

Transfer characteristics

 10^{-3} 10^{-2} 10^{-1} 10^{0}



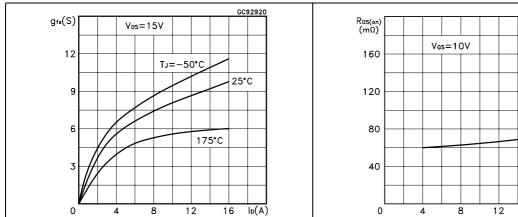
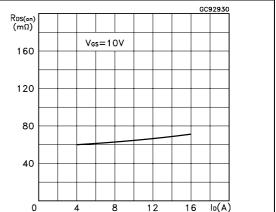


Figure 6. Static drain-source on resistance



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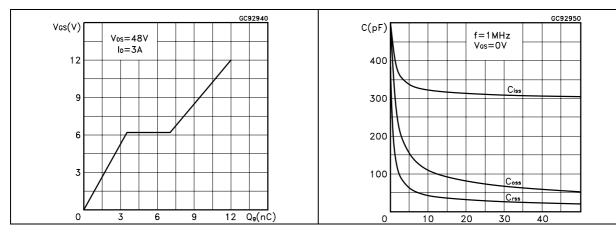
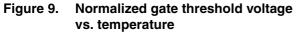


Figure 7. Gate charge vs. gate-source voltage Figure 8. Capacitance variations



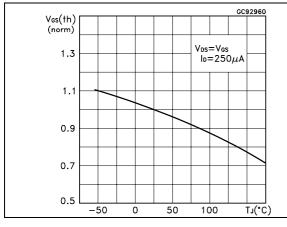


Figure 11. Source-drain diode forward characteristics

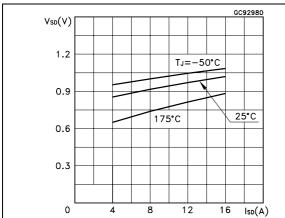


Figure 10. Normalized on resistance vs. temperature

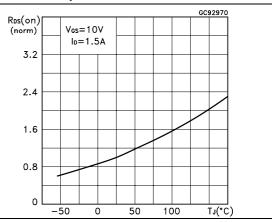
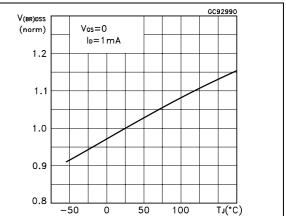


Figure 12. Normalized breakdown voltage vs. temperature



3 **Test circuit**

Figure 13. Switching times test circuit for resistive load

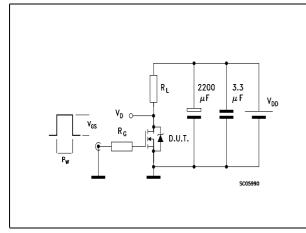
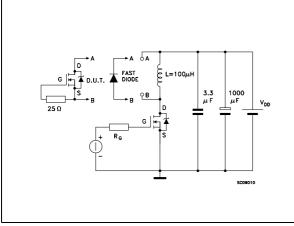


Figure 15. Test circuit for inductive load switching and diode recovery times





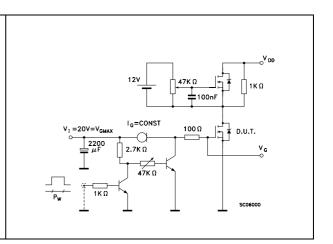


Figure 16. Unclamped Inductive load test circuit

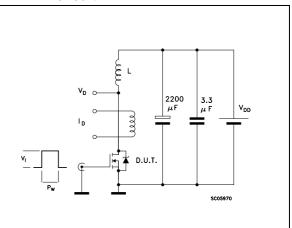


Figure 18. Switching time waveform

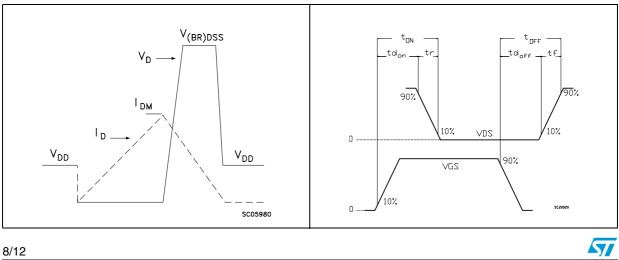


Figure 14. Gate charge test circuit

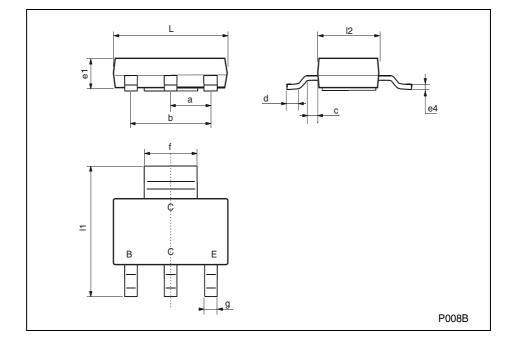
4 Package mechanical data

In order to meet environmental requirements, ST offers these devices in ECOPACK® packages. These packages have a Lead-free second level interconnect. The category of second level interconnect is marked on the package and on the inner box label, in compliance with JEDEC Standard JESD97. The maximum ratings related to soldering conditions are also marked on the inner box label. ECOPACK is an ST trademark. ECOPACK specifications are available at: www.st.com



DIM.	mm			mils		
	MIN.	TYP.	MAX.	MIN.	TYP.	MAX.
а	2.27	2.3	2.33	89.4	90.6	91.7
b	4.57	4.6	4.63	179.9	181.1	182.3
С	0.2	0.4	0.6	7.9	15.7	23.6
d	0.63	0.65	0.67	24.8	25.6	26.4
e1	1.5	1.6	1.7	59.1	63	66.9
e4			0.32			12.6
f	2.9	3	3.1	114.2	118.1	122.1
g	0.67	0.7	0.73	26.4	27.6	28.7
11	6.7	7	7.3	263.8	275.6	287.4
12	3.5	3.5	3.7	137.8	137.8	145.7
L	6.3	6.5	6.7	248	255.9	263.8

SOT-223 MECHANICAL DATA





5 Revision history

Table 7.	Revision	history
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Date	Revision	Changes
21-Jun-2004	4	Complete datasheet
04-Oct-2006	5	The document has been reformatted
01-Feb-2007	6	Typo mistake on Table 1.



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